

<b>Notice of References Cited</b>	Application/Control No. 10/078,106	Applicant(s)/Patent Under Reexamination TEDROW ET AL.	
	Examiner VanThu Nguyen	Art Unit 2824	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,233,177 B1	05-2001	Shokouhi et al.	365/185.23
*	B	US-6,016,270 A	01-2000	Thummalapally et al.	365/185.11
*	C	US-5,787,037	07-1998	Amanai, Masakazu	365/185.18
*	D	US-5,652,450	07-1997	Hirano, Yasuaki	257/323
*	E	US-5,371,705 A	12-1994	Nakayama et al.	365/185.23
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.